

<b>Notice of References Cited</b>	Application/Control No. 10/646,779	Applicant(s)/Patent Under Reexamination SANCHEZ, RAQUEL	
	Examiner Pierre-Louis Desir	Art Unit 2681	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0195962	10-2003	Kikuchi et al.	709/226
	B	US-2005/0054348	03-2005	Turina et al.	455/453
	C	US-6,091,953	07-2000	Ho et al.	455/433
	D	US-2003/0076803	04-2003	Chuah, Mooi Choo	370/338
	E	US-2001/0030941	10-2001	Musikka et al.	370/221
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2071776 A1	09-2002	World Intellect	ARTOLA et al.	H04Q 07/30
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.